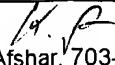


<b>Notice of References Cited</b>	Application/Control No. 10/003,153	Applicant(s)/Patent Under Reexamination LLOYD ET AL.	
	Examiner  Kamran Afshar, 703-305-7373	Art Unit 2681	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,344,727 B1	02-2002	Desai et al.	320/107
	B	US-6,127,802	10-2000	Lloyd et al.	320/107
	C	US-2002/0183101 A1	12-2002	Oh et al.	455/569
	D	US-D436,576 S	01-2001	Herrmann et al.	D13/107
	E	US-6,016,346	01-2000	Rittmueller et al.	379/420.02
	F	US-6,625,469 B1	09-2003	Hwang et al.	455/550.1
	G	US-6,526,150 B2	02-2003	Kelly et al.	455/569.1
	H	US-6,718,182 B1	04-2004	Kung, Shao-Tsu	455/556.1
	I	US-6,775,557	08-2004	Tsai, Irving	455/556.1
	J	US-6,266,542 B1	07-2001	Stern et al.	455/569.1
	K	US-5,588,041	12-1996	Meyer et al.	455/569.2
	L	US-5,749,057	05-1998	Takagi, Kotaro	455/569.2
	M	US-5,487,182	01-1996	Hansson, Hans M.	455/569.1

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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